



HPK EC minies irradiated by protons IV and CV characteristics

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Electrical tests of ATLAS12A Endcap mini sensors in Prague – status

- IV, CV
- Coupling Capacitance
- Rbias: Polysilicon Bias Resistance
- Cint: Interstrip Capacitance
- Rint: Interstrip Resistance
- PTP: Punch-through Protection

10 Unirradiated EC sensors

- measurements done,
- all characteristics tested
- results presented in ATLAS Upgrade Week:
<https://indico.cern.ch/getFile.py/access?contribId=71&sessionId=42&resId=1&materialId=slides&confId=233534>

20 Irradiated EC sensors

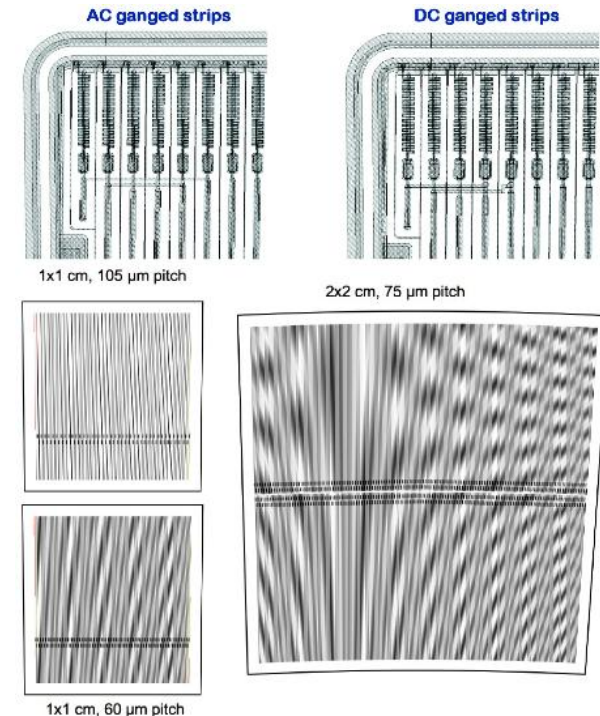
- sensors irradiated in Birmingham by 27 MeV protons up to 3 fluences 5E14, 1E15, 2E15 Neq/cm²
- delivered to Prague in November 2013
- measurements in progress
- up to now only IV and CV tested

Irradiated ATLAS12A EndCap mini sensors in Prague

Irradiation in Birmingham by 27 MeV protons up to 3 fluences 5E14, 1E15, 2E15 Neq/cm²

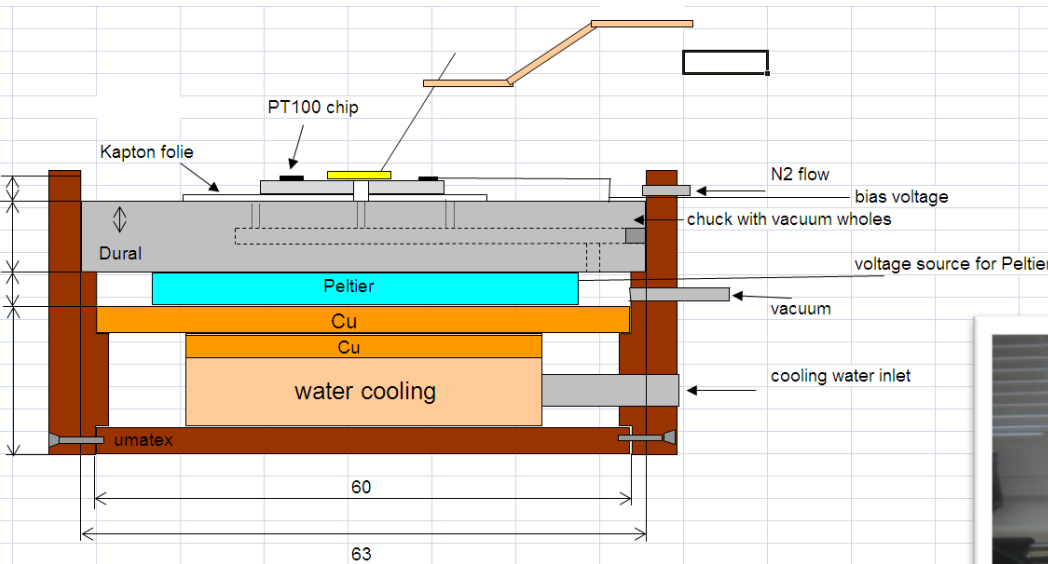
- 20 EC sensors in total (in Prague)
- 12 sensors already tested for IV and CV
- 6 of them measured before controlled annealing
- **9** of them annealed for 80 minutes at 60°C and measured

5E14 n _{eq} /cm ²	1E15 n _{eq} /cm ²	2E15 n _{eq} /cm ²
✓ W628-EC-Small-C-P7	✓ W620-EC-Small-C-P7	✓ W645-EC-Small-E-P8
✓ W604-EC-Large-C-P9	✓ W644-EC-Small-E-P8	✓ W605-EC-Large-C-P9
W626-EC-Large-E-P10	W628-EC-Large-E-P10	✓ W644-EC-Small-C-P17
✓ W639-EC-Small-E-P18	✓ W642-EC-Small-C-P17	✓ W604-EC-Small-E-P18
✓ W645-EC-Large-C-P19	✓ W626-EC-Large-C-P19	W642-EC-Large-E-P20
W620-Skewed-C-P01 (upper)	W609-EC-Large-E-P20	
W644-Skewed-E-P02 (lower)	W645-Skewed-E-P02 (lower)	W630-Skewed-C-P01 (upper)



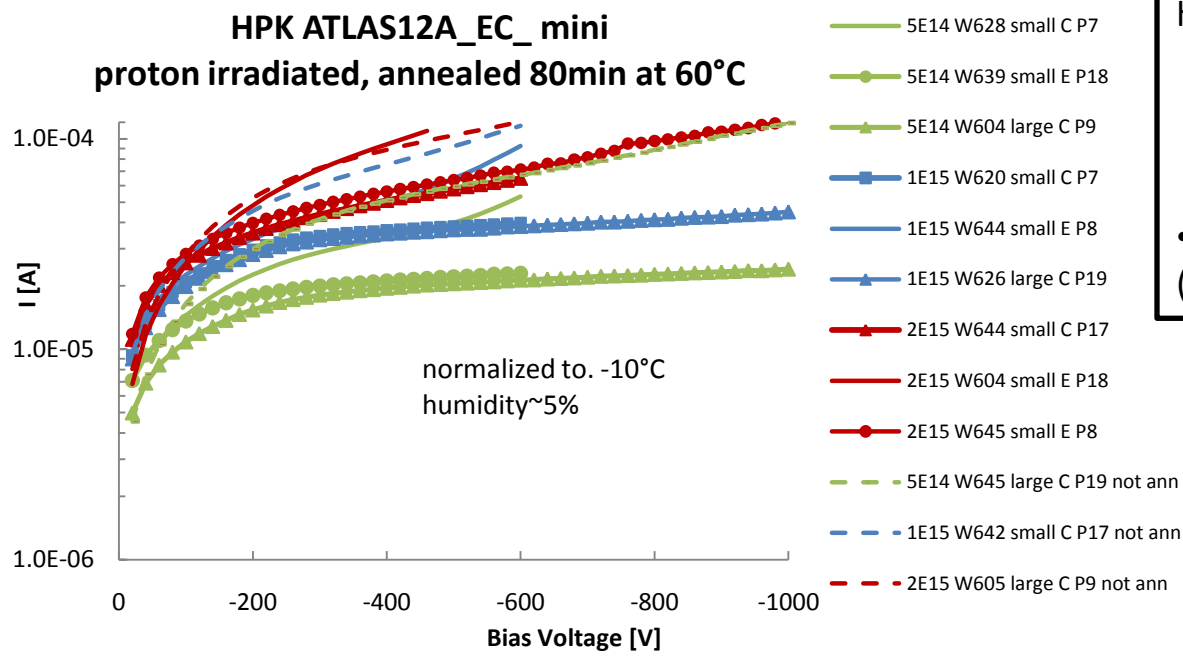
SETUP

- Proton Irradiated EC minies measured before and after annealing 80 minutes at 60°C
- Chuck cooled by Peltier module to -10°C
- Temperature measured by PT100 connected to chuck
- Nitrogen flow in probestation, humidity < 5%
- Nitrogen precooled down in freezer to avoid warming up sensor



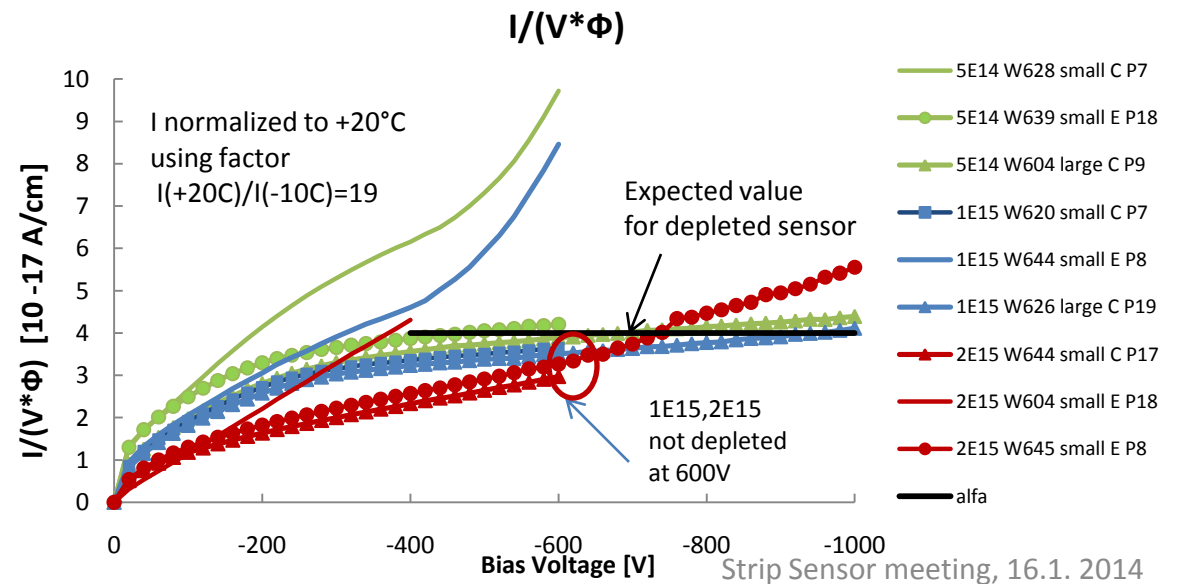
Leakage Current

- only 6 sensors from 12 sensor measured have "good" IV behavior up to 600V/1000V
 - "good": line with marker in the plot
 - "bad": just line, no marker
 - "bad" not annealed: dashed line
- Some of the "bads" have visible defects (see backup)



Leakage current per 1cm² at -10°C at 600V (average for each fluence)

Fluence [neq/cm ²]	I / A [μA/cm ²]	
	„Good“	„Bad“
Not irradiated at RT	0.004	
5E14	32.2	88
1E15	56.8	151
2E15	99.2	>> 160



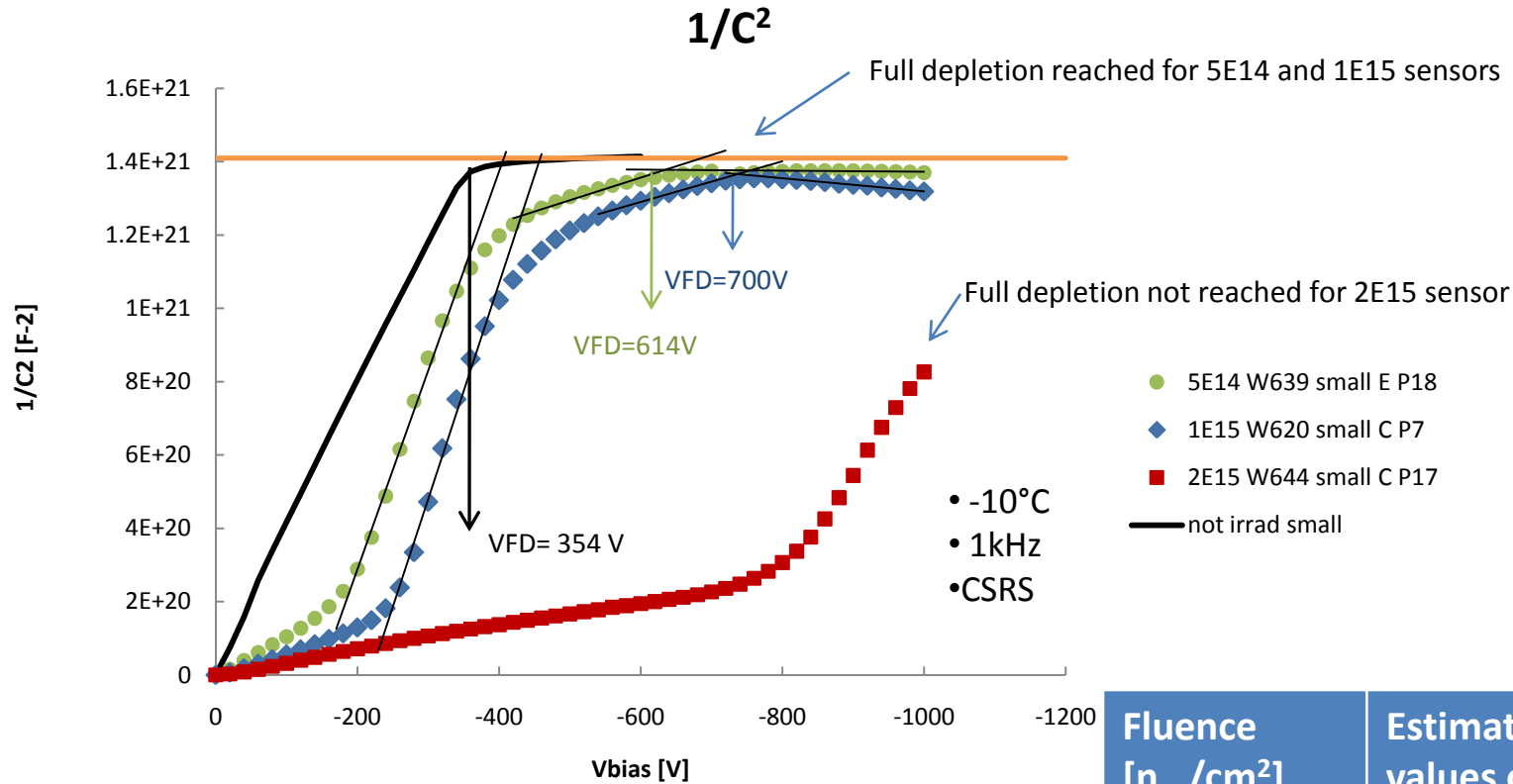
Damage parameter

$$\alpha = \frac{\Delta I}{V \cdot \Phi_{eq}}$$

Alfa = (3.99 ± 0.03)10⁻¹⁷ A/cm at 80min at 60°C for I at 20°C [M. Moll]

Active thickness: 302μm
Active area:
Large: 0.690 cm²
Small: 0.686 cm²

Full Depletion Voltage Determination

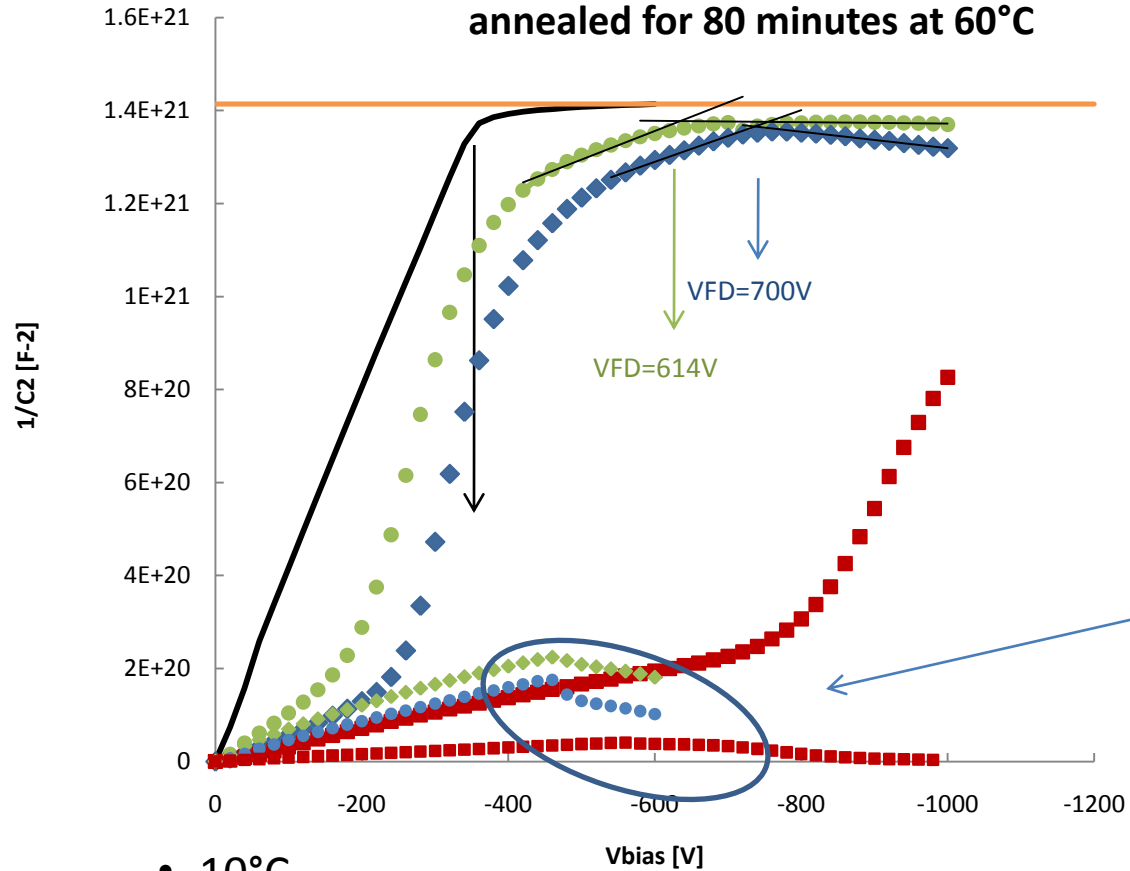


- Plot shows CV of “good” sensors only according to IV characteristics
- FDV extracted as crossing of the linear rise $1/C^2$ and the saturated value
- For sensors irradiated by 5E14 and 1E15 it's difficult to estimate FDV from CV measurement. It depends on a part of the linear rise which is fitted.
- For 2E15 sensors of 300um thickness it is impossible

Fluence [n_{eq}/cm^2]	Estimated values of V_{fd}	
Not irradiated	354 V	
5E14	614 V	360 V
1E15	700 V	440V
2E15	> 1000 V	> 1000V

CV characteristics

CV: Proton irradiated EC minies,
annealed for 80 minutes at 60°C

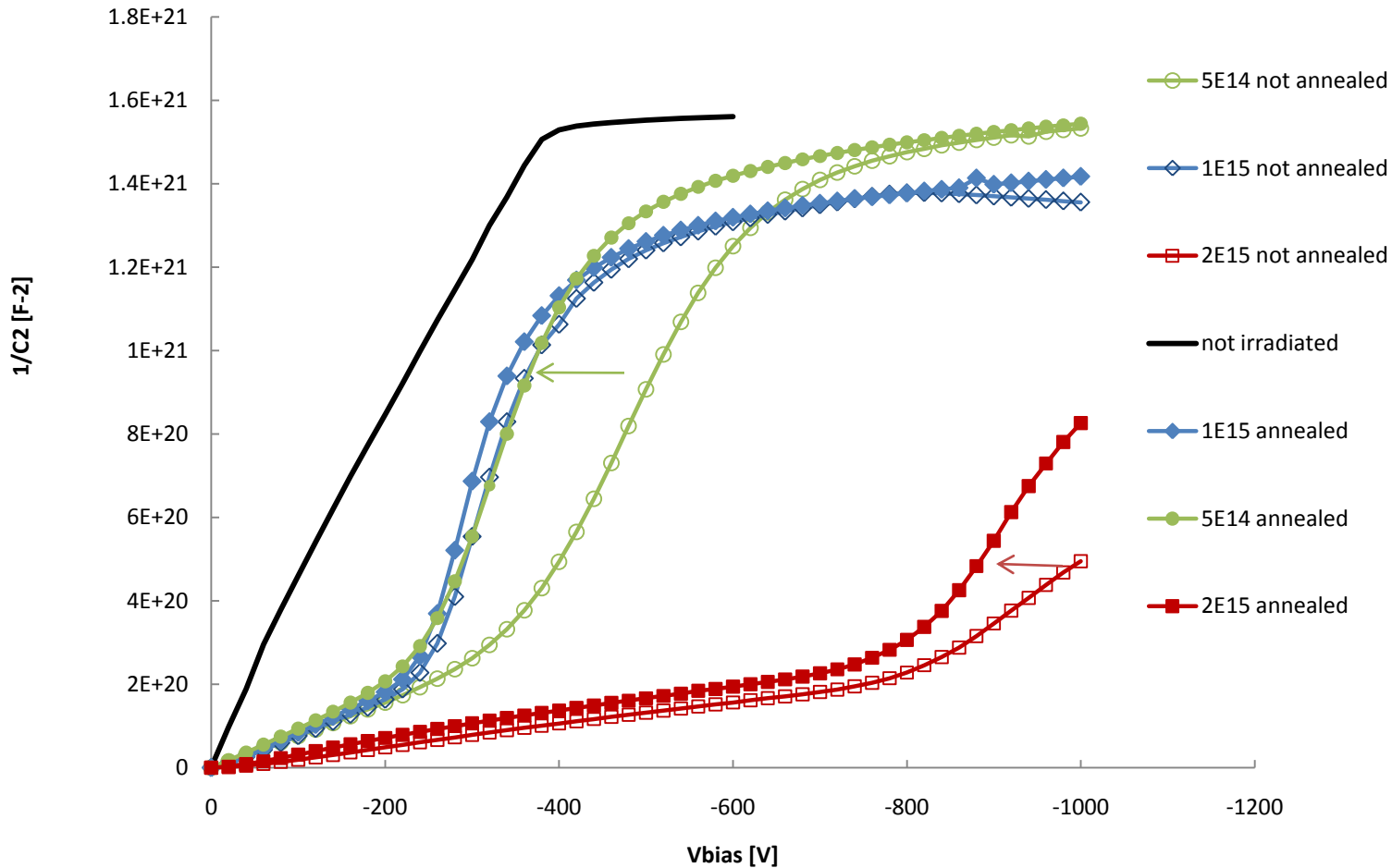


The plot includes also CV of “bad” sensors
with high leakage current

- 5E14 W639 small E P18
 - ◆ 1E15 W620 small C P7
 - 2E15 W644 C P17
 - not irradiated
 - ◆ 5E14 W628 small C P7
 - 1E15 W644 small E P8
 - 2E15 W604 small EP8
- “good”
- “bad”

- -10°C
- 1kHz
- CSRS

CV before and after annealing 80 minutes at 60° C



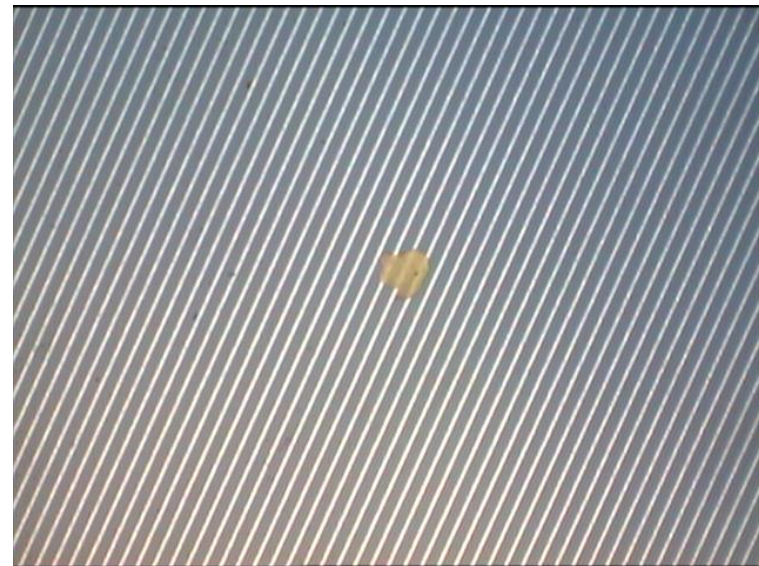
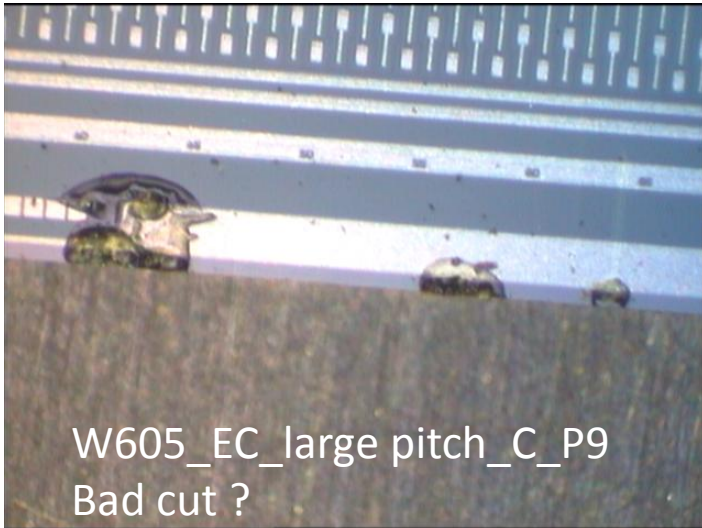
- Annealing shift of CV characteristics is visible on sensors irradiated by **2E15** and **5E14** n_{eq}/cm^2
- sensor irradiated by **1E15** looks like already annealed before controlled annealing

Conclusions

- IV and CV characteristics of ATLAS12A Endcap mini sensors irradiated by protons to $5E14$, $1E15$ and $2E15$ n_{eq}/cm^2 were measured
- Measurements done before controlled annealing and after annealing (80 minutes at $60^\circ C$) at $-10^\circ C$
- only 6 sensors from 12 sensor measured have “good” IV behavior up to $600V/1000V$
- The Full depletion voltage estimated from CV is
 - 610V for $5E14$ n_{eq}/cm^2
 - 700V for $1E15$
 - >> 1000V for $2E15$
- sensor irradiated by $1E15$ looks like already annealed before controlled annealing (no annealing shift of CV curve)

BackUp

Defects on irradiated EC minies



W642_EC_small pitch_C_P17

W605_EC_large pitch_C_P9
Possibly condensation of humidity?

Frequency dependence of Bulk capacitance at $V_{bias} > FDV$

